

Material No.: 2190-23 Batch No.: 0000244031

Manufactured Date: 2019/10/25 Expiration Date: 2021/04/24

Revision No: 1

Certificate of Analysis

| Test | Specification | Result |
|-----------------------------------|---------------|--------|
| Assay (H2O2) | 30.0 - 32.0 % | 31.6 |
| Color (APHA) | <= 10 | < 5 |
| ree Acid (µeq/g) | <= 0.2 | < 0.2 |
| Residue after Evaporation | <= 10 ppm | 2 |
| Ammonium (NH4) | <= 3 ppm | < 3 |
| Chloride (Cl) | <= 0.2 ppm | < 0.2 |
| Nitrate (NO3) | <= 2 ppm | < 2 |
| Phosphate (PO4) | <= 1 ppm | < 1 |
| Sulfate (SO ₄) | <= 3 ppm | < 3 |
| Frace Impurities - Aluminum (Al) | <= 70.0 ppb | 5.2 |
| Arsenic and Antimony (as As) | <= 10 ppb | < 10 |
| Frace Impurities – Barium (Ba) | <= 20.0 ppb | < 1.0 |
| Frace Impurities – Beryllium (Be) | <= 10.0 ppb | < 1.0 |
| Frace Impurities – Bismuth (Bi) | <= 20.0 ppb | < 10.0 |
| Frace Impurities – Boron (B) | <= 10.0 ppb | < 5.0 |
| Frace Impurities – Cadmium (Cd) | <= 10.0 ppb | < 1.0 |
| Frace Impurities – Calcium (Ca) | <= 50.0 ppb | 1.2 |
| Frace Impurities – Chromium (Cr) | <= 20.0 ppb | 2.4 |
| Frace Impurities – Cobalt (Co) | <= 10.0 ppb | < 1.0 |
| Frace Impurities – Copper (Cu) | <= 10.0 ppb | < 1.0 |
| Frace Impurities – Gallium (Ga) | <= 20.0 ppb | < 1.0 |
| Frace Impurities – Germanium (Ge) | <= 10.0 ppb | < 10.0 |
| Frace Impurities – Gold (Au) | <= 10.0 ppb | < 5.0 |
| Heavy Metals (as Pb) | <= 500 ppb | < 250 |

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|--|-------------------|--------|
| Trace Impurities – Iron (Fe) | <= 50.0 ppb | 6.2 |
| Trace Impurities - Lead (Pb) | <= 10.0 ppb | < 10.0 |
| Trace Impurities - Lithium (Li) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Magnesium (Mg) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Manganese (Mn) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Molybdenum (Mo) | <= 10.0 ppb | < 5.0 |
| Trace Impurities - Nickel (Ni) | <= 10.0 ppb | < 5.0 |
| Trace Impurities - Niobium (Nb) | <= 10.0 ppb | < 1.0 |
| Trace Impurities – Potassium (K) | <= 600.0 ppb | 198.6 |
| Trace Impurities - Silicon (Si) | <= 100.0 ppb | < 10.0 |
| Trace Impurities - Silver (Ag) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Sodium (Na) | <= 100.0 ppb | 7.9 |
| Trace Impurities - Strontium (Sr) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Tantalum (Ta) | <= 10.0 ppb | < 5.0 |
| Trace Impurities - Thallium (TI) | <= 50.0 ppb | < 5.0 |
| Trace Impurities - Tin (Sn) | 190.0 - 500.0 ppb | 352.3 |
| Trace Impurities - Titanium (Ti) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Vanadium (V) | <= 10.0 ppb | < 1.0 |
| Trace Impurities - Zinc (Zn) | <= 50.0 ppb | 2.0 |
| Trace Impurities – Zirconium (Zr) | <= 10.0 ppb | < 1.0 |
| Particle Count – 0.2 μm and greater, For Information Only | par/ml | 10 |
| Particle Count – 0.5 μm and greater | <= 100 par/ml | < 100 |

For Microelectronic Use

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC

